

Dual N-Channel MOSFET

General Description

The WSD25N10DN33 is the highest performance SGT Dual N-Channel MOSFET with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The WSD25N10DN33 meet the RoHS and Green Product requirement, 100% E_{AS} guaranteed with full function reliability approved.

Features

- 100% UIS Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

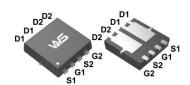
Product Summery

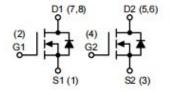
BV _{DSS}	$R_{DS(ON)}$	l _D
100V	19mΩ	25A

Applications

- Power Management for Industrial DC/DC Converters
- Ldeal for high-frequency switching and synchronous rectification

DFN3*3-8L Pin Configuration





Absolute Maximum Ratings (T_A=25°C, Unless Otherwise Noted)

Symbol	Parameter		Rating	Units
V _{DS}	Drain-Source Voltage		100	
V _{GS}	Gate-Source Voltage		±20	_ V
. 7		T _C =25°C	25	
I _D ⁷	Continuous Drain Current	T _C =100°C	18	A
I _{DM} ³	Pulse Drain Current	,	110	
P _D ²	Power Dissipation	T _C =25°C	28	W
I _{AS} ³	Single pulse Avalanche Current	,	18	А
E _{AS} ³	Single pulse Avalanche Energy	L=0.5mH	95	mJ
T _{STG}	Storage Temperature Range		-55 to 150	00
T _J	Operating Junction Temperature Range		-55 to 150	°C
D 14		t≤10s	30	
R _{θJA} ^{1,4}	Thermal Resistance-Junction to Ambient	Steady State	60.5	°C/W
$R_{ heta JC}$	Thermal Resistance-Junction to Case		4.5	



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Electrical Characteristics (T_J=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250μA	100			V
		V _{GS} =10V , I _D =10A		19	22	
R _{DS(ON)}	Static Drain-Source On-Resistance	T _J =125°C		36		mΩ
		V_{GS} =4.5 V , I_{D} =10 A		22	25	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_{D}=250\mu A$	1.3	1.8	2.3	V
	Duein Course Leekens Current	V _{DS} =100V , V _{GS} =0V			1.0	
I _{DSS}	Drain-Source Leakage Current	T _J =55°C			5.0	μA
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V , V _{GS} =±20V			±100	nA
9 _{fs}	Forward Transconductance	V_{DS} =5V , I_{D} =10A		23		S
R _G	Gate Resistance	f=1.0MHz		4.5		Ω
Q_{g}	Total Gate Charge (10V)			12.5		
Q_{gs}	Gate-Source Charge	V_{DS} =50V , V_{GS} =10V , I_{D} =10A		2		nC
Q_{gd}	Gate-Drain Charge			3		
T _{d(on)}	Turn-On Delay Time			15		
T _r	Rise Time	V_{DD} =50V , V_{GS} =10V , I_{D} =10A		16		
T _{d(off)}	Turn-Off Delay Time	$R_L=1\Omega$, $R_{GEN}=3\Omega$		23		ns
T _f	Fall Time	, 551		7		
C _{iss}	Input Capacitance			580		
C _{oss}	Output Capacitance	V _{DS} =50V , V _{GS} =0V , <i>f</i> =1.0MHz		167		pF
C _{rss}	Reverse Transfer Capacitance			6		

Diode Characteristics

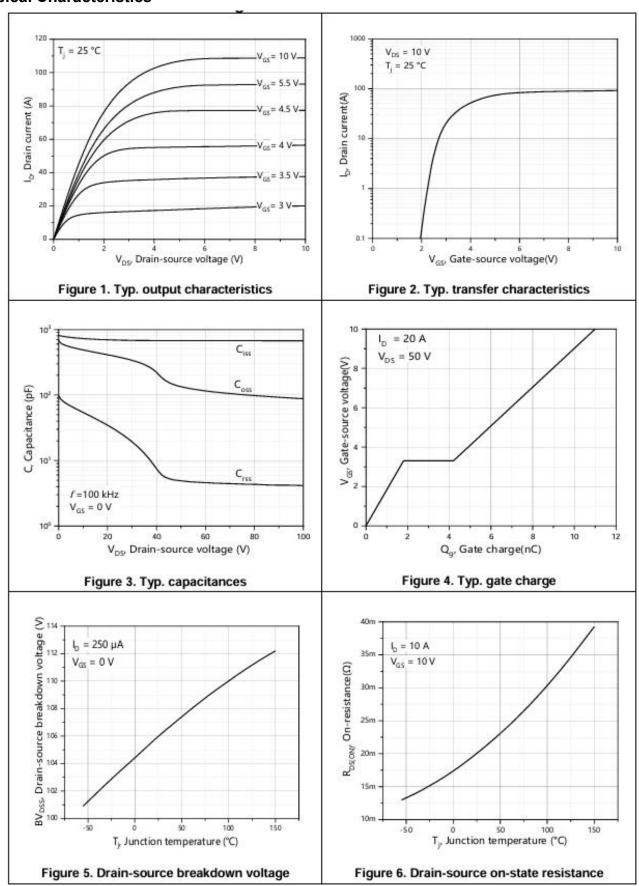
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I _S ⁷	Continuous Source Current				25	Α
V _{SD}	Diode Forward Voltage V _{GS} =0V , I _S =1A			0.7	1.2	V
t _{rr}	Reverse Recovery Time	I _E =20A , di/dt=500A/µs		45		ns
Q _{rr}	Reverse Recovery Charge	1 _F -20A , αl/αι-300A/μs		89		nC

Note:

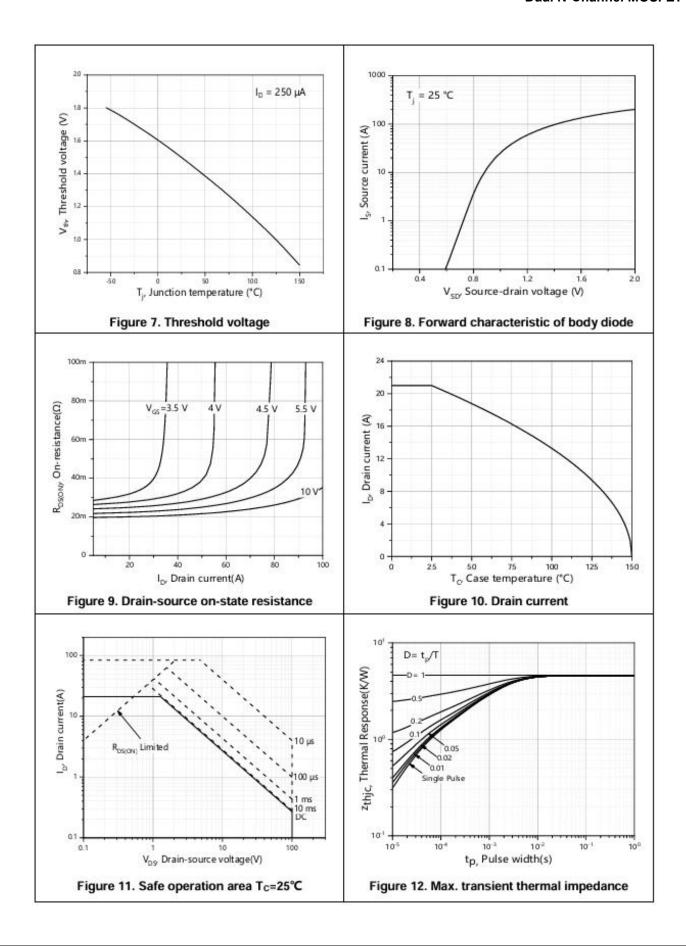
- 1. The value of R_{BJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The Power dissipation P_{DSM} is based on R_{BJA} t≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 2. The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. Single pulse width limited by junction temperature $T_{J(MAX)}$ =150°C.
- 4. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- 5. The static characteristics in Figures 1 to 6 are obtained using $<300\mu s$ pulses, duty cycle 0.5% max.
- 6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150°C. The SOA curve provides a single pulse rating.
- 7. The maximum current rating is package limited.
- 8. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C.
- 9. The maximum current rating is silicon limited



Typical Characteristics

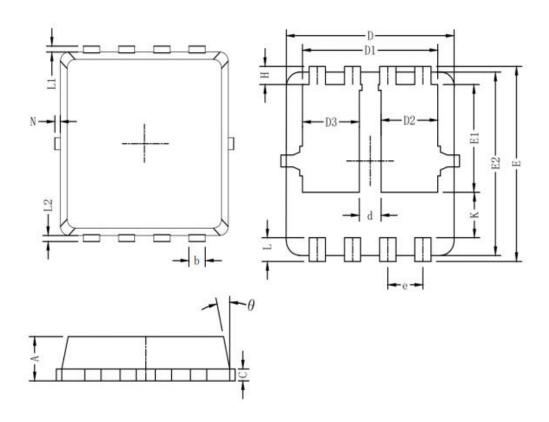








Packaging information



Symbol		Dim in mm	
	min	typ	max
Α	0.6	0.75	0.9
b	0.2	0.3	0.4
С	0.15	0.2	0.25
D	3	3.1	3.2
D1	2.3	2.45	2.6
D2/D3	0.8	1	1.2
E	3.15	3.3	3.45
E1	1.43	1.73	1.93
E2	2.9	3.05	3.2
е	0.65BSC		
Н	0.2	0.35	0.5
K	0.57	0.77	0.87
L	0.3	0.4	0.5
L1/L2	0.1REF		
θ	8°	10°	13°
N	0		0.15
d	0.3	0.4	0.5





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